

UNISONIC TECHNOLOGIES CO., LTD

UT40N25H **Preliminary POWER MOSFET**

40A, 250V N-CHANNEL POWER MOSFET

DESCRIPTION

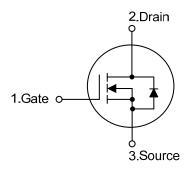
The UTC UT40N25H is a N-channel mode power MOSFET using UTC's advanced technology to provide customers with a minimum on-state resistance, low gate charge and high switching

The UTC UT40N25H is suitable for high voltage synchronous rectifier and DC/DC converters, etc.

FEATURES

- * $R_{DS(ON)} \le 62 \text{ m}\Omega$ @ $V_{GS}=10V$, $I_{D}=20A$
- * High Switching Speed
- * High Cell Density Trench Technology

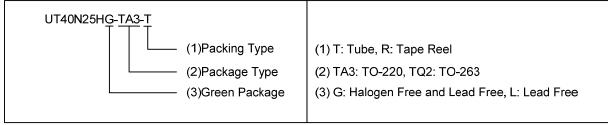
SYMBOL

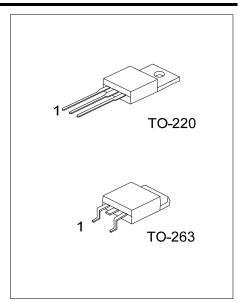


ORDERING INFORMATION

Ordering Number		Doolsons	Pin	Assignm	Doolsing		
Lead Free	Halogen Free	Package	1	2	3	Packing	
UT40N25HL-TA3-T	UT40N25HG-TA3-T	TO-220	G	D	S	Tube	
UT40N25HL-TQ2-T	UT40N25HG-TQ2-T	TO-263	G	D	S	Tube	
UT40N25HL-TQ2-R	UT40N25HG-TQ2-R	TO-263	G	D	S	Tape Reel	

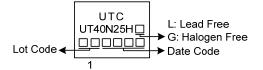
Note: Pin Assignment: G: Gate D: Drain S: Source





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MARKING



■ ABSOLUTE MAXIMUM RATING (T_C=25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain-Source Voltage		V_{DSS}	250	V
Gate-Source Voltage		V_{GSS}	±20	V
Drain Current	Continuous	I_{D}	40	Α
	Pulsed (Note 2)	I_{DM}	120	Α
Avalanche Energy (Note 3)	lanche Energy (Note 3) Single Pulsed (Note 3)		5	mJ
Peak Diode Recovery dv/dt (Note 4)		dv/dt	3.8	V/ns
Power Dissipation		P_{D}	120	W
Junction Temperature		T_J	+150	°C
Storage Temperature Range		T_{STG}	-40 ~ +150	°C

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

- 2. Repetitive Rating: Pulse width limited by maximum junction temperature
- 3. L=0.1mH, I_{AS} =10.6A, V_{DD} =50V, R_G = 25 Ω , Starting T_J = 25 $^{\circ}$ C
- 4. $I_{SD} \le 30A$, di/dt $\le 200A/\mu s$, $V_{DD} \le BV_{DSS}$, Starting $T_J = 25^{\circ}C$

■ THERMAL DATA

PARAMETER	SYMBOL	RATINGS	UNIT	
Junction to Ambient	θ_{JA}	62.5	°C/W	
Junction to Case (Note)	θјς	1.04	°C/W	

Note: Device mounted on FR-4 substrate Pc board, 2oz copper, with 1inch square copper plate.

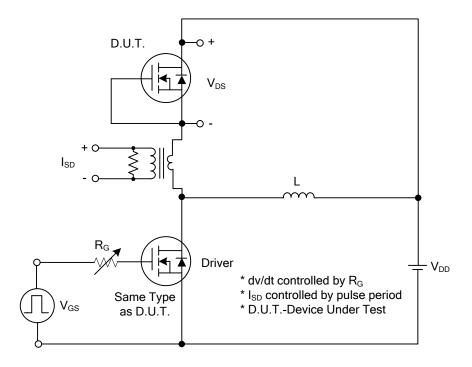
■ ELECTRICAL CHARACTERISTICS (T_J =25°C, unless otherwise specified)

PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT	
OFF CHARACTERISTICS								
Drain-Source Breakdown Voltage		BV _{DSS}	I _D =250μA, V _{GS} =0V	250			V	
Drain-Source Leakage Current		I _{DSS}	V _{DS} =250V, V _{GS} =0V			1	μΑ	
Gate-Source Leakage Current	Forward		V _{GS} =+20V, V _{DS} =0V			+100	nA	
	Reverse	I _{GSS}	V _{GS} =-20V, V _{DS} =0V			-100	nA	
ON CHARACTERISTICS								
Gate Threshold Voltage		$V_{GS(TH)}$	$V_{DS}=V_{GS}$, $I_D=250\mu A$	2.0		4.0	V	
Static Drain-Source On-State Resistance		R _{DS(ON)}	V_{GS} =10V, I_D =20A			62	mΩ	
DYNAMIC PARAMETERS								
Input Capacitance		C _{ISS}			9405		pF	
Output Capacitance		Coss	V_{GS} =0V, V_{DS} =25V, f=1.0MHz		290		pF	
Reverse Transfer Capacitance	C_{RSS}			222		pF		
SWITCHING PARAMETERS								
Total Gate Charge (Note 1)		Q_{G}	V _{DS} =200V, V _{GS} =10V, I _D =40A		190		nC	
Gate to Source Charge		Q_{GS}	(Note 1, 2)		45		nC	
Gate to Drain Charge		Q_GD	(Note 1, 2)		54		nC	
Turn-on Delay Time (Note 1)		$t_{D(ON)}$			28		ns	
Rise Time		t_R	V _{DS} =100V, V _{GS} =10V, I _D =40A,		20		ns	
Turn-off Delay Time		t _{D(OFF)}	R _G =3Ω (Note 1, 2)		70		ns	
Fall-Time		t_{F}			25		ns	
SOURCE- DRAIN DIODE RATINGS AND CHARACTERISTICS								
Maximum Body-Diode Continuous Current		I _S				40	Α	
Maximum Body-Diode Pulsed Current		I _{SM}				120	Α	
Drain-Source Diode Forward Voltage (Note 1)		V_{SD}	I _S =40A, V _{GS} =0V			1.4	V	
Body Diode Reverse Recovery Time		t _{rr}	I _S =30A, V _{GS} =0V,		150		ns	
Reverse Recovery Charge		Q_{rr}	dI _F /dt=100A/μs (Note 1)		0.92		μC	

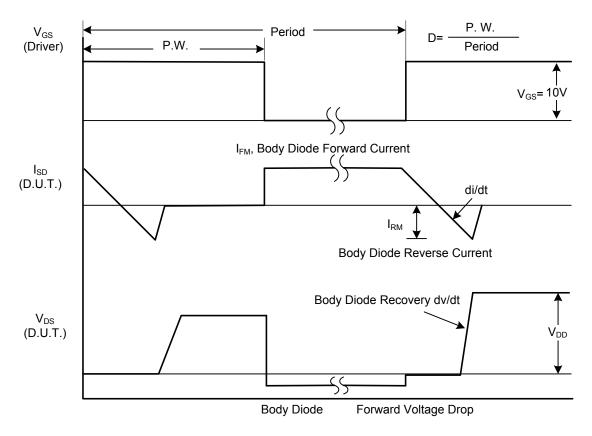
Notes: 1. Pulse Test: Pulse width ≤ 300µs, Duty cycle ≤ 2 %.

^{2.} Essentially independent of operating temperature.

■ TEST CIRCUITS AND WAVEFORMS

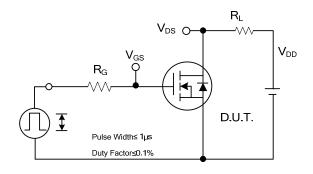


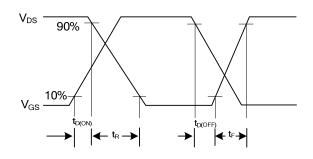
Peak Diode Recovery dv/dt Test Circuit



Peak Diode Recovery dv/dt Waveforms

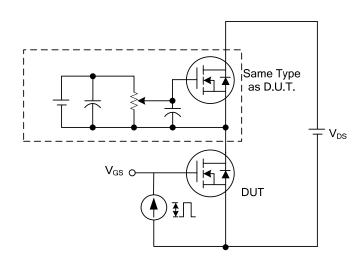
TEST CIRCUITS AND WAVEFORMS

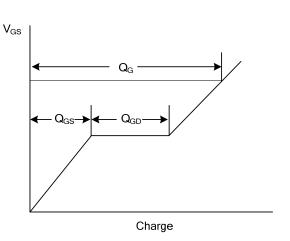




Switching Test Circuit

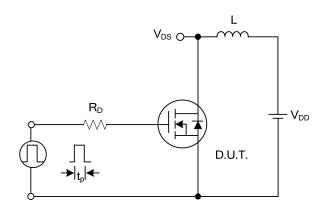
Switching Waveforms

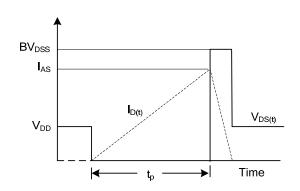




Gate Charge Test Circuit

Gate Charge Waveform





Unclamped Inductive Switching Test Circuit

Unclamped Inductive Switching Waveforms

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